International TOR Rectifier

IRF4905S/L

- Advanced Process Technology
- Surface Mount (IRF4905S)
- Low-profile through-hole (IRF4905L)
- 175°C Operating Temperature
- Fast Switching
- P-Channel
- Fully Avalanche Rated

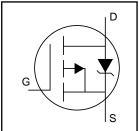
Description

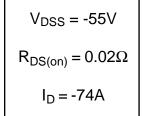
Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

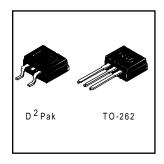
The D²Pak is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible onresistance in any existing surface mount package. The D²Pak is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0W in a typical surface mount application.

The through-hole version (IRF4905L) is available for low-profile applications.

HEXFET® Power MOSFET







Absolute Maximum Ratings

	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ -10VS	-74	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ -10V ^⑤	-52	A
I _{DM}	Pulsed Drain Current ①⑤	-260	
P _D @T _A = 25°C	Power Dissipation	3.8	W
$P_{D} @ T_{C} = 25^{\circ}C$	Power Dissipation	200	W
	Linear Derating Factor	1.3	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
E _{AS}	Single Pulse Avalanche Energy ② ⑤	930	mJ
I _{AR}	Avalanche Current®	-38	A
E _{AR}	Repetitive Avalanche Energy®	20	mJ
dv/dt	Peak Diode Recovery dv/dt 3 \$	-5.0	V/ns
T _J	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		.€
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	

Thermal Resistance

	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case		0.75	0000
R _{eJA}	Junction-to-Ambient (PCB Mounted,steady-state)**		40	°C/W

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	-55			V	$V_{GS} = 0V, I_{D} = -250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		-0.05		V/°C	Reference to 25°C, I _D = -1mA ^⑤
R _{DS(on)}	Static Drain-to-Source On-Resistance			0.02	Ω	V _{GS} = -10V, I _D = -38A ④
V _{GS(th)}	Gate Threshold Voltage	-2.0		-4.0	V	$V_{DS} = V_{GS}$, $I_D = -250\mu A$
g _{fs}	Forward Transconductance	21			S	$V_{DS} = -25V, I_{D} = -38A$ (5)
Lac	Drain-to-Source Leakage Current			-25	μA	$V_{DS} = -55V, V_{GS} = 0V$
I _{DSS}	Brain to Oddroe Eddhage Carrent			-250	μΛ	$V_{DS} = -44V, V_{GS} = 0V, T_{J} = 150$ °C
1	Gate-to-Source Forward Leakage			100	nA	V _{GS} = 20V
I _{GSS}	Gate-to-Source Reverse Leakage			-100	''^	$V_{GS} = -20V$
Qg	Total Gate Charge			180		I _D = -38A
Q _{gs}	Gate-to-Source Charge			32	nC	$V_{DS} = -44V$
Q_{gd}	Gate-to-Drain ("Miller") Charge			86]	V _{GS} = -10V, See Fig. 6 and 13 ⊕ ⑤
t _{d(on)}	Turn-On Delay Time		18			$V_{DD} = -28V$
t _r	RiseTime		99		200	$I_D = -38A$
t _{d(off)}	Turn-Off Delay Time		61		ns	$R_G = 2.5\Omega$
t _f	FallTime		96			$R_D = 0.72\Omega$, See Fig. 10 ④
I.	Internal Source Inductance		7.5		· nH	Between lead,
L _S						and center of die contact
C _{iss}	Input Capacitance		3400			V _{GS} = 0V
Coss	Output Capacitance		1400		pF	$V_{DS} = -25V$
C _{rss}	Reverse Transfer Capacitance		640			$f = 1.0MHz$, See Fig. 5 \circ

Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current			-74		MOSFET symbol
	(Body Diode)			-/4	A	showing the
I _{SM}	Pulsed Source Current			200		integral reverse
	(Body Diode) ①		-260		p-n junction diode.	
V _{SD}	Diode Forward Voltage			-1.6	V	T _J = 25°C, I _S = -38A, V _{GS} = 0V ④
t _{rr}	Reverse Recovery Time		89	130	ns	$T_J = 25$ °C, $I_F = -38A$
Qrr	Reverse Recovery Charge		230	350	nC	di/dt = -100A/µs ④⑤
ton	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D)				

④ Pulse width \leq 300µs; duty cycle \leq 2%.

S Uses IRF4905 data and test conditions

Notes:

- Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- $\begin{tabular}{ll} \hline @ Starting $T_J = 25^{\circ}C$, $L = 1.3mH$ \\ $R_G = 25\Omega$, $I_{AS} = -38A$. (See Figure 12) \\ \hline \end{tabular}$
- $\ \Im \ I_{SD} \leq \text{-38A}, \ di/dt \leq \text{-270A/}\mu s, \ V_{DD} \leq V_{(BR)DSS}, \\ T_J \leq 175 ^{\circ} C$
- ** When mounted on 1" square PCB (FR-4 or G-10 Material).
 For recommended footprint and soldering techniques refer to application note #AN-994.

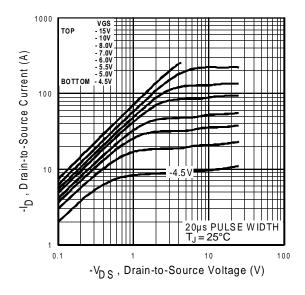


Fig 1. Typical Output Characteristics

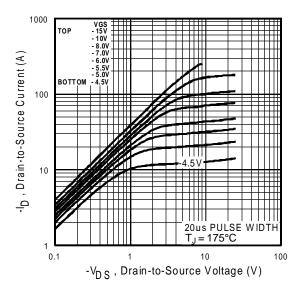


Fig 2. Typical Output Characteristics

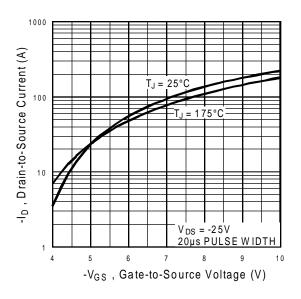


Fig 3. Typical Transfer Characteristics

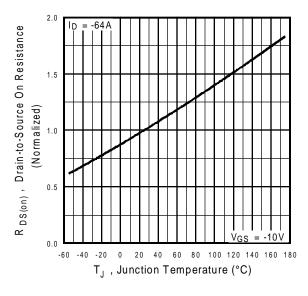


Fig 4. Normalized On-Resistance Vs. Temperature

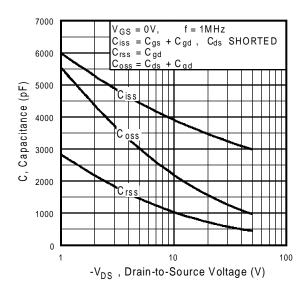


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

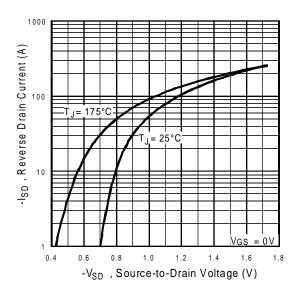


Fig 7. Typical Source-Drain Diode Forward Voltage

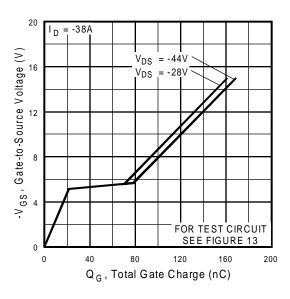


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

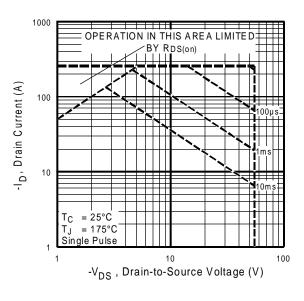


Fig 8. Maximum Safe Operating Area

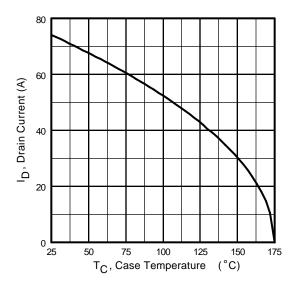


Fig 9. Maximum Drain Current vs. Case Temperature

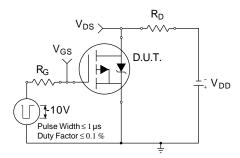


Fig 10a. Switching Time Test Circuit

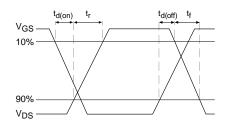


Fig 10b. Switching Time Waveforms

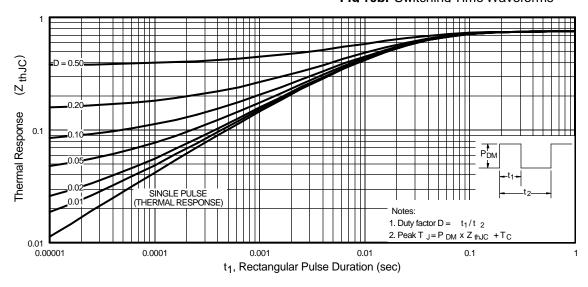


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

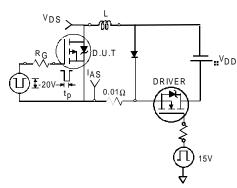


Fig 12a. Unclamped Inductive Test Circuit

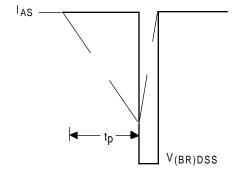


Fig 12b. Unclamped Inductive Waveforms

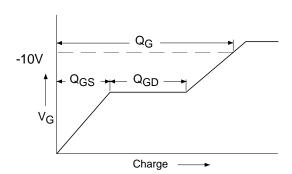


Fig 13a. Basic Gate Charge Waveform

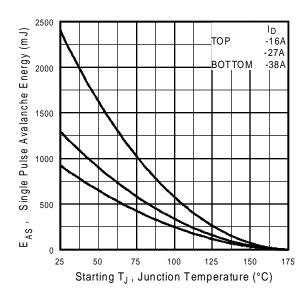


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

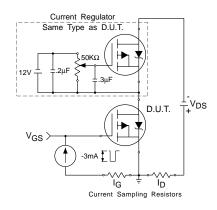
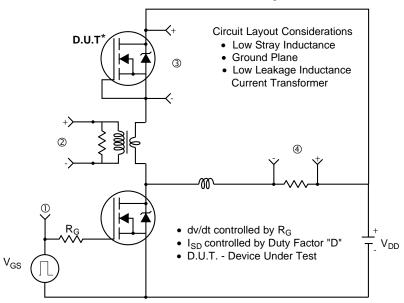
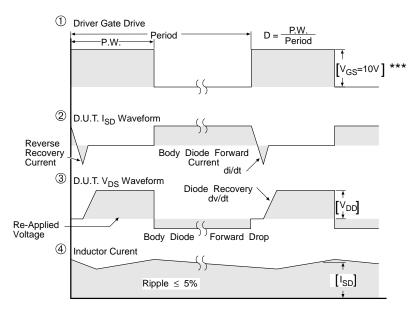


Fig 13b. Gate Charge Test Circuit

Peak Diode Recovery dv/dt Test Circuit



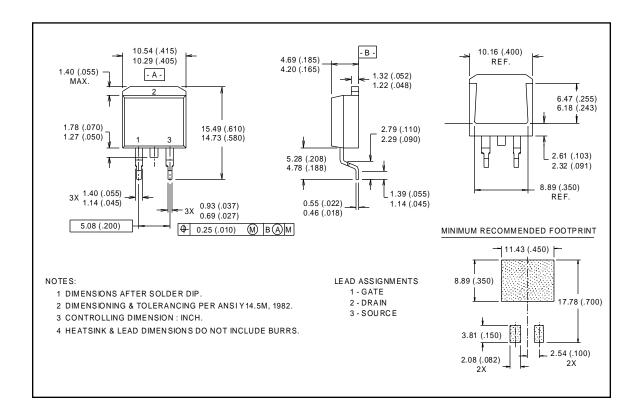
^{*} Reverse Polarity of D.U.T for P-Channel



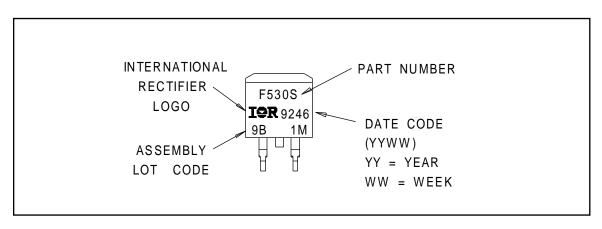
*** $V_{GS} = 5.0V$ for Logic Level and 3V Drive Devices

Fig 14. For P-Channel HEXFETS

D²Pak Package Outline

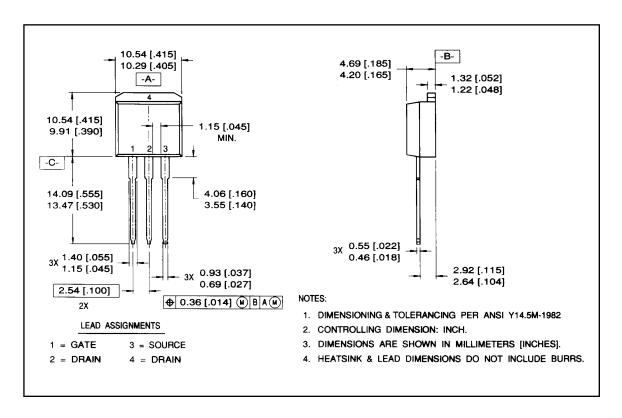


Part Marking Information D²Pak

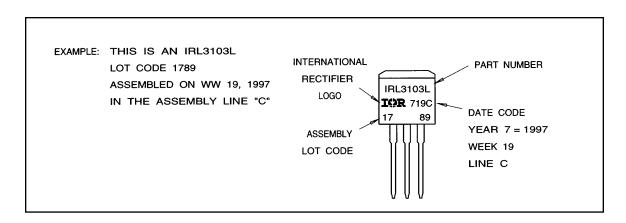


Package Outline

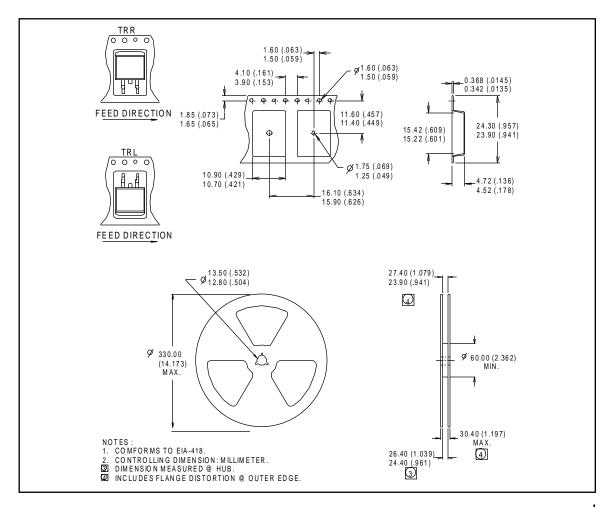
TO-262 Outline



Part Marking Information To-262



Tape & Reel Information D²Pak



International Rectifier

WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, Tel: (310) 322 3331 EUROPEAN HEADQUARTERS: Hurst Green, Oxted, Surrey RH8 9BB, UK Tel: ++ 44 1883 732020 IR CANADA: 7321 Victoria Park Ave., Suite 201, Markham, Ontario L3R 2Z8, Tel: (905) 475 1897 IR GERMANY: Saalburgstrasse 157, 61350 Bad Homburg Tel: ++ 49 6172 96590

IR ITALY: Via Liguria 49, 10071 Borgaro, Torino Tel: ++ 39 11 451 0111

IR FAR EAST: K&H Bldg., 2F, 30-4 Nishi-Ikebukuro 3-Chome, Toshima-Ku, Tokyo Japan 171 Tel: 81 3 3983 0086
IR SOUTHEAST ASIA: 315 Outram Road, #10-02 Tan Boon Liat Building, Singapore 0316 Tel: 65 221 8371
http://www.irf.com/ Data and specifications subject to change without notice. 8/97